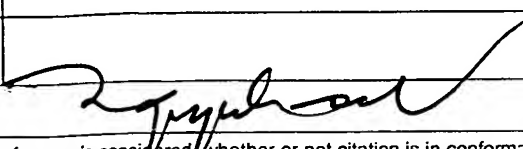


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 248772US2CRL		SERIAL NO. 10/777,185	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Timothy David FARNHAM, et al.			
				FILING DATE February 13, 2004		GROUP 2618	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AA	AA	2001-0051530 A1	12/13/01	Shiotsu et al.	—	—	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
AO	AO	2001-345756	12/14/01	Japan		X	
AP	AP	7-283763	10/27/95	Japan		X	
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner						Date Considered <u>01/02/08</u>	
*Examiner: Initial if reference is considered whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 248772US2CRL		SERIAL NO. 10/777,185	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Timothy David FARNHAM, et al.			
				FILING DATE February 13, 2004		GROUP 2618	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
<i>DM</i>	AA	6,993,358, B2	01/31/06	Shlotsu et al.	<u>1</u>	<u>1</u>	
<i>DK</i>	AB	7,016,676 B2	03/21/06	Walke et al.	<u>1</u>	<u>1</u>	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>DM</i>	AO	2001-345756	12/14/01	Japan (w/computer generated English translation corresponding to U.S. Patent No. 6,993,358)	X		
	AP	2004-506381	02/26/04	Japan (corresponding to WO 02/13457 and U.S. Patent No. 7,016,676)	X		
	AQ	2002-542639	12/10/02	Japan (w/computer generated partial English translation corresponding to WO 00/49824)	X		
	AR	WO 02/13457 A2	02/14/02	WIPO			
<i>DM</i>	AS	WO 00/49824	08/24/00	WIPO			
	AT	2004-274745	09/30/04	Japan (w/English Abstract)			
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner NGUYEN, T.					Date Considered 11/5/07		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							